

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









# **STGW25H120DF2**, **STGWA25H120DF2**

Trench gate field-stop IGBT, H series 1200 V, 25 A high speed

Datasheet - production data

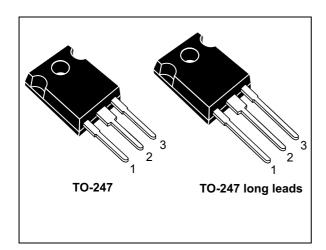
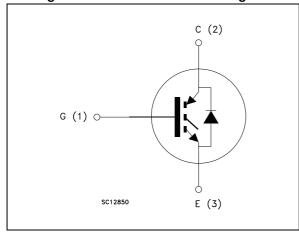


Figure 1. Internal schematic diagram



#### **Features**

- Maximum junction temperature: T<sub>J</sub> = 175 °C
- · High speed switching series
- Minimized tail current
- $V_{CE(sat)} = 2.1 \text{ V (typ.)} @ I_C = 25 \text{ A}$
- 5  $\mu$ s minimum short circuit withstand time at  $T_{,l}$ =150 °C
- Safe paralleling
- Very fast recovery antiparallel diode
- Low thermal resistance

#### **Applications**

- Uninterruptible power supply
- Welding machines
- Photovoltaic inverters
- · Power factor correction
- High frequency converters

## **Description**

These devices are IGBTs developed using an advanced proprietary trench gate field-stop structure. These devices are part of the H series of IGBTs, which represent an optimum compromise between conduction and switching losses to maximize the efficiency of high switching frequency converters. Moreover, a slightly positive  $V_{\text{CE(sat)}}$  temperature coefficient and very tight parameter distribution result in safer paralleling operation.

Table 1. Device summary

Order code	Marking	Package	Packaging
STGW25H120DF2	G25H120DF2	TO-247	Tube
STGWA25H120DF2	G25H120DF2	TO-247 long leads	Tube

## **Contents**

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuits
4	Package information
	4.1 TO-247, package information
	4.2 TO-247 long leads, package information
5	Revision history



# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-emitter voltage (V <sub>GE</sub> = 0)	1200	V
1.	Continuous collector current at T <sub>C</sub> = 25 °C	50	Α
I <sub>C</sub>	Continuous collector current at T <sub>C</sub> = 100 °C	25	Α
I <sub>CP</sub> <sup>(1)</sup>	Pulsed collector current	100	Α
V <sub>GE</sub>	Gate-emitter voltage	±20	V
	Continuous collector current at T <sub>C</sub> = 25 °C	50	Α
IF	Continuous collector current at T <sub>C</sub> = 100 °C	25	Α
I <sub>FP</sub> <sup>(1)</sup>	Pulsed forward current	100	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	375	W
T <sub>J</sub>	Operating junction temperature	– 55 to 175	°C
T <sub>STG</sub>	Storage temperature range	- 55 to 150	

<sup>1.</sup> Pulse width limited by maximum junction temperature.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thJC</sub>	Thermal resistance junction-case IGBT	0.4	°C/W
R <sub>thJC</sub>	Thermal resistance junction-case diode	1.47	°C/W
R <sub>thJA</sub>	Thermal resistance junction-ambient	50	°C/W

## 2 Electrical characteristics

 $T_J = 25$  °C unless otherwise specified.

**Table 4. Static characteristics** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)CES</sub>	Collector-emitter breakdown voltage (V <sub>GE</sub> = 0)	I <sub>C</sub> = 2 mA	1200			٧
		V <sub>GE</sub> = 15 V, I <sub>C</sub> = 25 A		2.1	2.6	
V O = ( 1)	Collector-emitter saturation voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 25 A T <sub>J</sub> = 125 °C		2.4		٧
	Tolkago	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 25 A T <sub>J</sub> = 175 °C		2.5		
		I <sub>F</sub> = 25 A		3.8	4.9	
V <sub>F</sub>	Forward on-voltage	I <sub>F</sub> = 25 A, T <sub>J</sub> = 125 °C		3.05		٧
		I <sub>F</sub> = 25 A, T <sub>J</sub> = 175 °C		2.8		
V <sub>GE(th)</sub>	Gate threshold voltage	$V_{CE} = V_{GE}$ , $I_C = 1 \text{ mA}$	5	6	7	٧
I <sub>CES</sub>	Collector cut-off current (V <sub>GE</sub> = 0)	V <sub>CE</sub> = 1200 V			25	μΑ
I <sub>GES</sub>	Gate-emitter leakage current (V <sub>CE</sub> = 0)	V <sub>GE</sub> = ± 20 V			250	nA

**Table 5. Dynamic characteristics** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>ies</sub>	Input capacitance		-	2010	-	pF
C <sub>oes</sub>	Output capacitance	$V_{CE} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GE} = 0$ $V_{CC} = 960 \text{ V, I}_{C} = 25 \text{ A,}$ $V_{GE} = 15 \text{ V, see } Figure 29$	-	146	-	pF
C <sub>res</sub>	Reverse transfer capacitance		-	49	-	pF
$Q_g$	Total gate charge		-	100	-	nC
Q <sub>ge</sub>	Gate-emitter charge		-	11	-	nC
Q <sub>gc</sub>	Gate-collector charge		-	52	-	nC

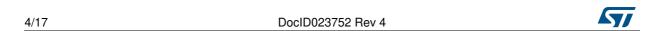


Table 6. IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time		-	29	-	ns
t <sub>r</sub>	Current rise time		-	12	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope		-	1774	-	A/μs
t <sub>d(off)</sub>	Turn-off delay time	$V_{CE} = 600 \text{ V}, I_{C} = 25 \text{ A},$		130	-	ns
t <sub>f</sub>	Current fall time	$R_G = 10 \Omega$ , $V_{GE} = 15 V$ , see <i>Figure 28</i>	-	106	-	ns
E <sub>on</sub> <sup>(1)</sup>	Turn-on switching losses	<b>3</b>	-	0.6	-	mJ
E <sub>off</sub> <sup>(2)</sup>	Turn-off switching losses		-	0.7	-	mJ
E <sub>ts</sub>	Total switching losses		-	1.3	-	mJ
t <sub>d(on)</sub>	Turn-on delay time		-	27.5	-	ns
t <sub>r</sub>	Current rise time		-	13.5	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope		-	1522	-	A/μs
t <sub>d(off)</sub>	Turn-off delay time	$V_{CE} = 600 \text{ V}, I_{C} = 25 \text{ A},$	-	139	-	ns
t <sub>f</sub>	Current fall time	$R_G = 10 \Omega$ , $V_{GE} = 15 V$ , $T_J = 175 °C$ , see <i>Figure 28</i>	-	200	-	ns
E <sub>on</sub> <sup>(1)</sup>	Turn-on switching losses		-	1.05	-	mJ
E <sub>off</sub> <sup>(2)</sup>	Turn-off switching losses		-	1.65	-	mJ
E <sub>ts</sub>	Total switching losses		-	2.7	-	mJ
t <sub>sc</sub>	Short-circuit withstand time	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$ $T_{J} = 150 ^{\circ}\text{C},$	5		-	μs

<sup>1.</sup> Energy losses include reverse recovery of the external diode.

Table 7. Diode switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>rr</sub>	Reverse recovery time		-	303	-	ns
Q <sub>rr</sub>	Reverse recovery charge	05 4 1/ 000 1/	-	0.93	-	μC
I <sub>rrm</sub>	Reverse recovery current	$I_F = 25 \text{ A}, V_R = 600 \text{ V},$ $di/dt=500 \text{ A/}\mu\text{s}, V_{GF} = 15 \text{ V},$	-	15.3	-	Α
dI <sub>rr/</sub> /dt	Peak rate of fall of reverse recovery current during t <sub>b</sub>	see Figure 28	-	400	-	A/μs
E <sub>rr</sub>	Reverse recovery energy		-	0.52	-	mJ
t <sub>rr</sub>	Reverse recovery time		-	508	-	ns
Q <sub>rr</sub>	Reverse recovery charge		-	2.71	-	μC
I <sub>rrm</sub>	Reverse recovery current	$I_F = 25 \text{ A}, V_R = 600 \text{ V},$ $di/dt = 500 \text{ A/}\mu\text{s}, V_{GF} = 15 \text{ V},$	-	23	-	Α
dI <sub>rr/</sub> /dt	Peak rate of fall of reverse recovery current during t <sub>b</sub>	$T_J = 175 ^{\circ}\text{C}$ , see <i>Figure 28</i>	-	680	-	A/μs
E <sub>rr</sub>	Reverse recovery energy		-	1.56	-	mJ

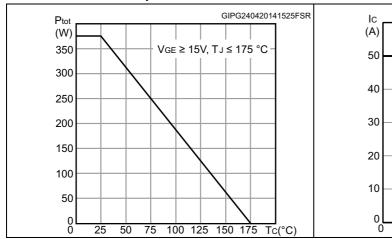


<sup>2.</sup> Turn-off losses include also the tail of the collector current.

### 2.1 Electrical characteristics (curves)

Figure 2. Power dissipation vs. case temperature

Figure 3. Collector current vs. case temperature



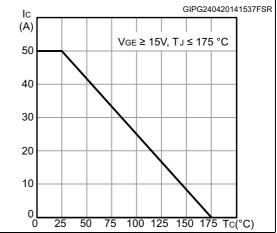
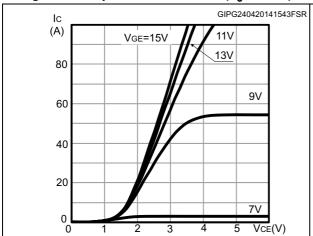


Figure 4. Output characteristics  $(T_J = 25^{\circ}C)$ 

Figure 5. Output characteristics  $(T_J = 175^{\circ}C)$ 



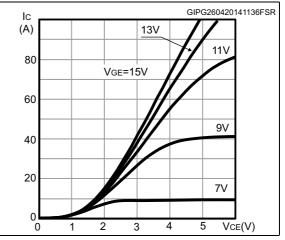
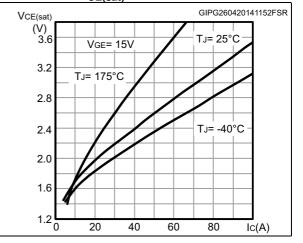


Figure 6. V<sub>CE(sat)</sub> vs. junction temperature

Figure 7. V<sub>CE(sat)</sub> vs. collector current

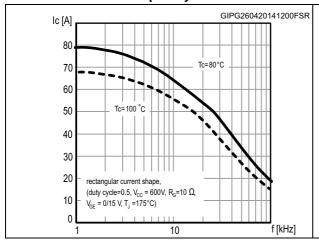


577

6/17 DocID023752 Rev 4

Figure 8. Collector current vs. switching frequency

Figure 9. Forward bias safe operating area



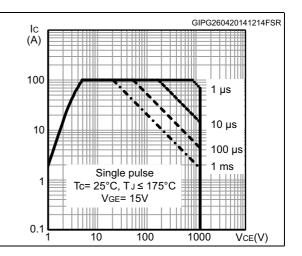
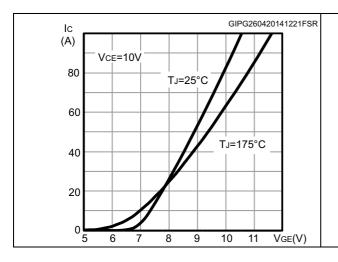


Figure 10. Transfer characteristics

Figure 11. Normalized V<sub>GE(th)</sub> vs junction temperature



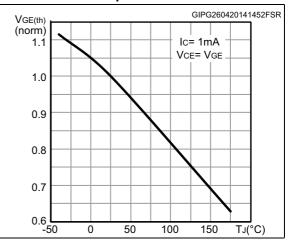
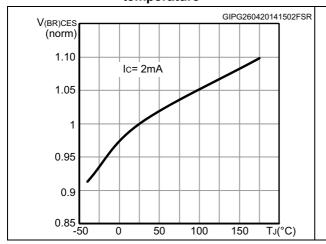


Figure 12. Normalized  $V_{(BR)CES}$  vs. junction temperature

Figure 13. Capacitance variation



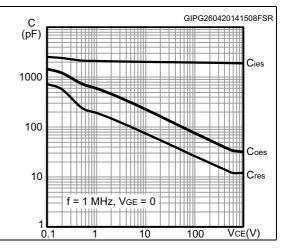


Figure 14. Gate charge vs. gate-emitter voltage Figure 15. Switching loss vs collector current

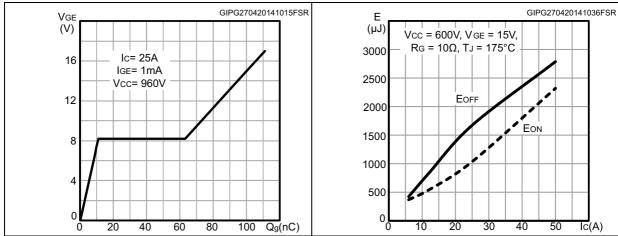


Figure 16. Switching loss vs gate resistance

Figure 17. Switching loss vs temperature

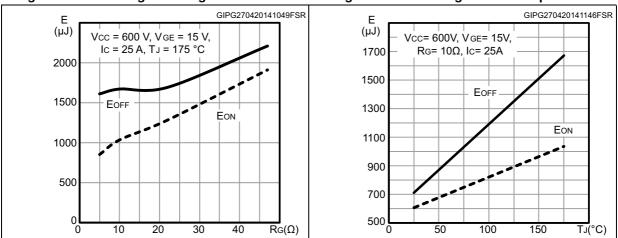
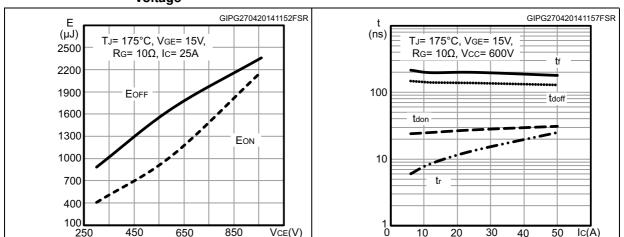


Figure 18. Switching loss vs collector-emitter Figure 19. Switching times vs. collector current voltage



8/17 DocID023752 Rev 4

Figure 20. Switching times vs. gate resistance Figure 21. Reverse recovery current vs. diode current slope

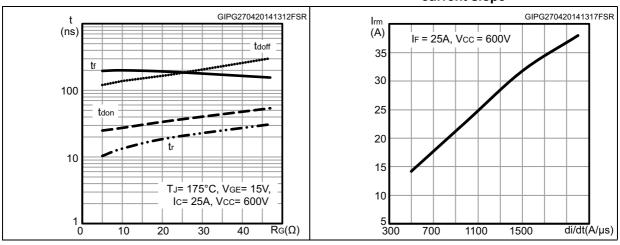


Figure 22. Reverse recovery time vs. diode current slope

Figure 23. Reverse recovery charge vs. diode current slope

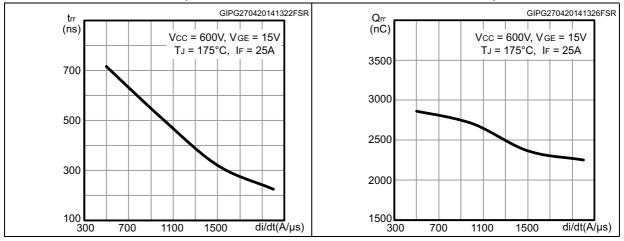
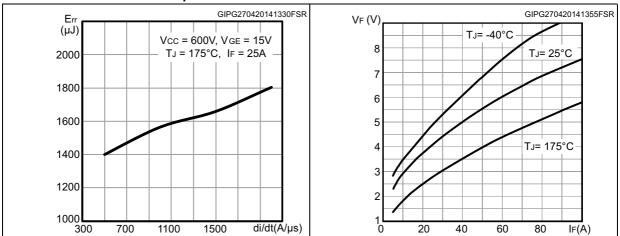


Figure 24. Reverse recovery energy vs. diode current slope

Figure 25. Diode  $V_{\rm F}$  vs. forward current





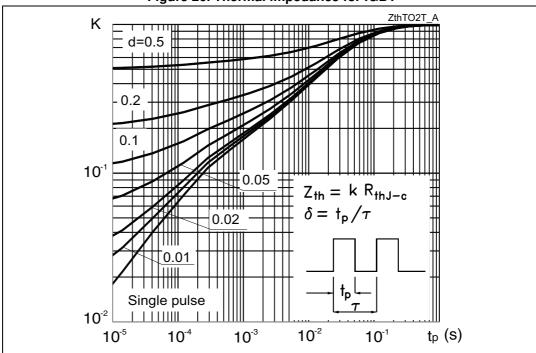
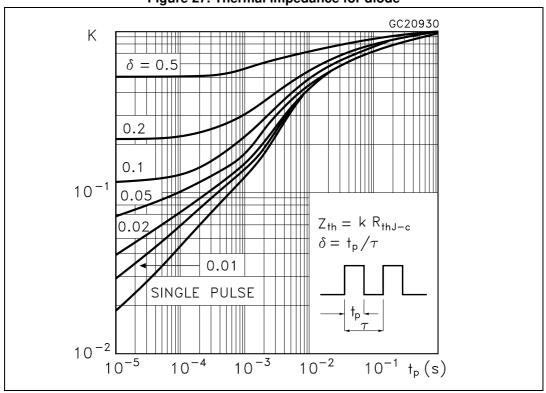


Figure 26. Thermal impedance for IGBT





10/17 DocID023752 Rev 4

## 3 Test circuits

Figure 28. Test circuit for inductive load switching

Figure 29. Gate charge test circuit

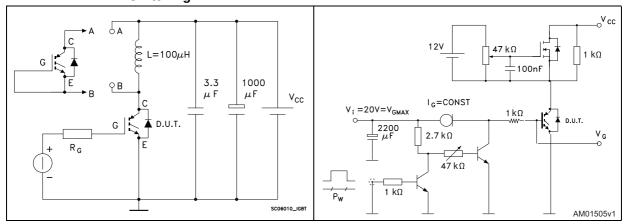
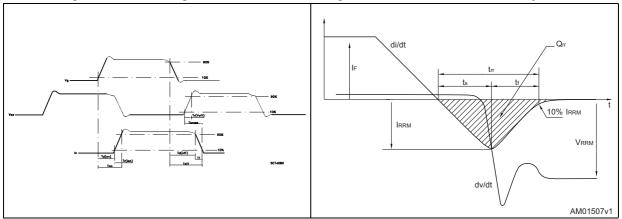


Figure 30. Switching waveform

Figure 31. Diode reverse recovery waveform



## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

### 4.1 TO-247, package information

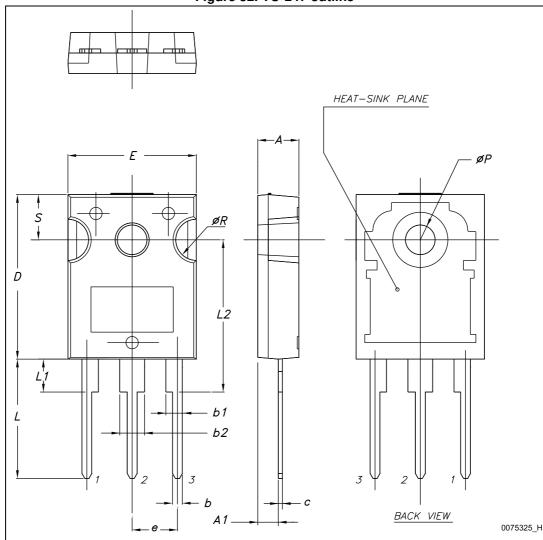


Figure 32. TO-247 outline

4

Table 8. TO-247 mechanical data

Dim.		mm.	
Dim.	Min.	Тур.	Max.
Α	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70



## 4.2 TO-247 long leads, package information

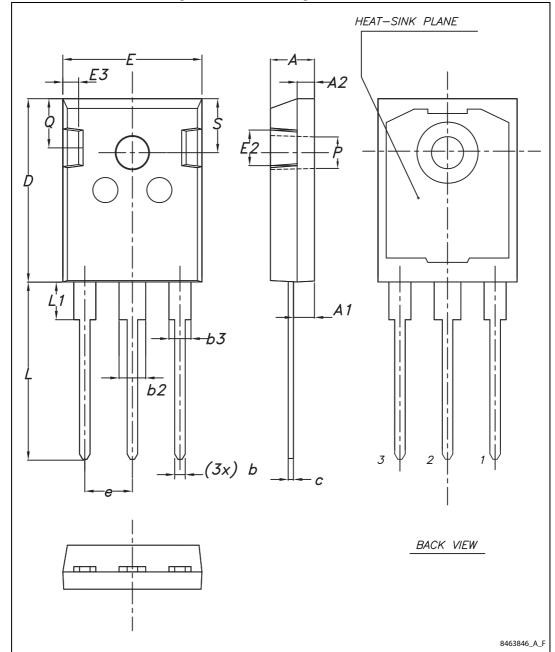


Figure 33. TO-247 long leads outline

Table 9. TO-247 long leads mechanical data

Dime		mm	
Dim.	Min.	Тур.	Max.
А	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
С	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
е	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
Р	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25



16/17

# 5 Revision history

Table 10. Document revision history

Date	Revision	Changes
03-Oct-2012	1	Initial release.
28-Feb-2014	2	Updated title and features in cover page. Minor text changes.
31-Mar-2014	3	Document status promoted from preliminary to production data.  Updated Table 4: Static characteristics and Table 6: IGBT switching characteristics (inductive load).  Added Section 2.1: Electrical characteristics (curves).
06-Mar-2015	4	Added 4.2: TO-247 long leads, package information Minor text changes.



#### **IMPORTANT NOTICE - PLEASE READ CAREFULLY**

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics - All rights reserved

